ARMI MBH

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Certificate of Analysis

ISO ISO ISO/IEC 17034:2016 17025:2017 9001:2015

> Revision No.: 000 Revision Date: 04/17/2023

Product ID: IARM-TI5553-21

Certified Reference Material

Product Description: Titanium Alloy, Ti 5553, Ti-5AI-5Mo-5V-3Cr

Description and Intended Use: This Certified Reference Material is covered under the scope of accreditation to ISO 17034 by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in ISO 17025 accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

				Certifi	ed Value	s listed in	wt.% wit	h ass	sociated	uncertaintie	s		
AI	5.60	±0.05		Н	0.0020	• ±0.000	7	0	0.14	±0.01	W	0.002	± 0.001
С	0.010	±0.002	2	Mn	0.0008	± 0.000	2	Ρ	0.002	±0.002	Zr	0.0018	± 0.0008
Cr	2.98	±0.03		Мо	4.99	±0.05		S	0.0008	±0.0005			
Cu	0.0019	±0.000)6	Ν	0.0036	5 ±0.000	6	Si	0.028	±0.006			
Fe	0.353	±0.007		Ni	0.0022	± 0.000	6	V	5.04	±0.05			
Indicative Values listed in ppm													
	В	10	Со	26	Nb	61 S	n 58		Ta 28	B Ti	balance	Y 8	3

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where Nprod is the number of units produced and Nmin is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (Uhom). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

$$1.N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$

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$$2.U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

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Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- Anderson Laboratories, Inc. Greendale, WI
- Applied Technical Services Marietta, GA
- Dirats Laboratories Westfield, MA
 - . Elemental Analysis Inc. - Lexington, KY •
- Eurofins EAG Laboratory Liverpool, NY
- IMR Test Labs Lansing, NY Laboratory Testing, Inc. - Hatfield, PA
- LGC Standards Manchester, NH
- New Hampshire Materials Laboratory Inc Somersworth, NH .
 - NSL Analytical Services Cleveland, OH
- Scrooby's Laboratory Service Pty Ltd Benoni, South Africa •
- SGS MSi Melrose Park, IL
- Sheffield Assay Office Sheffield, England
- TEC Eurolab Campogalliano, Italy

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use.

Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

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Chuck Goudreau, Certifying Officer

April 17, 2023 Certification Date



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01

Conditions of Sale and Supply: All CRMs & RMs sold are subject to applicable LGC Standard Terms and Conditions of Sale.

Page 1 of 2



The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	AI	В	С	Co	Cr	Cu	Fe	н	Mn	Мо	N	Nb	Ni
1	5.4040	0.0007	0.0060	0.0001	2.8800	0.0011	0.3260	н 0.0005	0.0007	4.8050	0.0022	0.0005	0.0009
2	5.4040	0.0007	0.0060	0.0001	2.8900	0.0011	0.3260	0.0005	0.0007	4.8630	0.0022	0.0005	0.0009
3	5.4550	0.0009	0.0071	0.0013	2.8960	0.0012	0.3360	0.0011	0.0007	4.8780	0.0031	0.0030	0.0010
4	5.4790	0.0010	0.0073	< 0.0004	2.9140	0.0012	0.3390	0.0012	0.0007	4.8800	0.0032	0.0039	0.0010
5	5.5220	< 0.00005	0.0087	< 0.0001	2.9410	0.0016	0.3390	0.0014	0.0007	4.0000	0.0035	0.0048	0.0019
5 6	5.5700	< 0.00005	0.0007	< 0.0005	2.9410	0.0016	0.3420	0.0020	0.0008	4.9195	0.0038	0.0087	0.0025
7	5.5820	< 0.0005	0.0104	< 0.0010	2.9421	0.0021	0.3467	0.0021	0.0010	4.9200	0.0038	0.0087	0.0025
8	5.5880	<0.0005	0.0106	< 0.0010	2.9537	0.0022	0.3520	0.0025	0.0010	4.9600	0.0039	0.0092	0.0025
9	5.6188	< 0.0010	0.0108	<0.005	2.9593	0.0030	0.3540	0.0023	< 0.0012	5.0200	0.0043	< 0.0005	0.0029
10	5.6417	< 0.0010	0.0100	<0.005	2.9800	< 0.0005	0.3540	0.0031	< 0.0003	5.0289	< 0.0048	<0.0005	0.0030
11	5.6466	< 0.003	0.0114	< 0.003	2.9930	< 0.0005	0.3570	0.0034	<0.0010	5.0350	~0.0005	<0.0003	< 0.0005
12	5.6500	< 0.01	0.0120	<0.01	3.0080	<0.005	0.3584		< 0.0010	5.0384		< 0.0010	< 0.0005
13	5.6600	NU.01	0.0132	NU.UT	3.0170	<0.005	0.3619		< 0.005	5.0400		< 0.005	<0.005
14	5.6620		0.0141		3.0470	< 0.003	0.3620		< 0.005	5.0720		< 0.005	<0.005
14	5.6862		0.0100		3.0604	< 0.01	0.3690		-0.000	5.0720		-0.000	< 0.003
16	5.7100				3.0640	NU.U1	0.3090			5.1357			<0.01
17	5.7400				3.0820		0.3700			5.1900			~0.01
18	5.7540				0.0020		0.3710			0.1000			
Mean	5.6004	0.0010	0.0104	0.0026	2.9757	0.0019	0.3533	0.0020	0.0008	4.9907	0.0036	0.0061	0.0022
STDV	0.1043	0.0010	0.0104	0.0020	0.0635	0.0019	0.0140	0.0020	0.0008	0.1033	0.0038	0.0035	0.0022
Certified	5.60	(0.0010)	0.0027	(0.0034	2.98	0.0008	0.353	0.0009	0.0002	4.99	0.0008	(0.0055	0.0008
U _{CRM}	0.05	(0.0010)	0.002	(0.0020)	0.03	0.0019	0.007	0.0020	0.0000	0.05	0.0006	(0.0001)	0.0022
Methods	0.03 0.1.X	I,G,IM	0.002 0,C,G	I,G,IM,X	0.03 0,1,1M,G,X	0.0000 0,I,IM,X	0,I,IM,G,X	F	0.0002 0,1,1M,X	0.03 0,1,1M,G,2		O,I,IM,X	0.0000 0,1,1M,G,X
Methods	0,1,7	1,0,111	0,0,0	1,0,111,7	0,1,1111,0,7	0,1,111,7	0,1,111,0,7		0,1,1111,7	0,1,111,0,7	\	0,1,1111,7	0,1,111,0,7
	0	Р	Pd	S	Si	Sn	Та	Ti	v	W	Y	Zr	
1	0.1240	0.0008	< 0.00005	0.0002	0.0160	0.0011	0.0005	80.2500	4.8860	0.0007	0.0006	0.0002	
2	0.1260	0.0009	< 0.0001	0.0004	0.0174	0.0014	0.0007	80.8533	4.8921	0.0007	0.0008	0.0012	
3	0.1300	0.0023	< 0.0001	0.0009	0.0183	0.0015	0.0019	81.1000	4.8970	0.0009	0.0010	0.0015	
4	0.1310	0.0024	< 0.0005	0.0010	0.0200	0.0018	0.0080		4.9690	0.0018	< 0.00005	0.0017	
5	0.1339	0.0030	< 0.0010	0.0011	0.0200	0.0033	< 0.0005		4.9706	0.0022	< 0.0005	0.0018	
6	0.1340	0.0048	< 0.0010	0.0014	0.0208	0.0054	< 0.0005		4.9860	0.0033	< 0.0005	0.0020	
7	0.1370	< 0.0005	< 0.005	< 0.0002	0.0240	0.0057	< 0.0010		4.9930	< 0.0005	< 0.001	0.0030	
8	0.1410	<0.005	<0.01	< 0.001	0.0243	0.0080	< 0.002		5.0040	<0.0010	< 0.005	0.0034	
9	0.1527	<0.005		< 0.0010	0.0249	0.0102	< 0.002		5.0100	< 0.005		< 0.0005	
10	0.1599	<0.005		< 0.005	0.0319	0.0123	< 0.002		5.0130			< 0.0005	
11	0.1670	<0.0050		< 0.005	0.0320	0.0130	<0.005		5.0220			<0.0010	
12		<0.01			0.0357	<0.0005	<0.01		5.0500			< 0.005	
13					0.0359	<0.005			5.1500				
14					0.0381	<0.01			5.1570				
14					0.0450	<0.01			5.1600				
15 16									5.1800				
15					0.0450				5.1800 5.2037				
15 16					0.0450				5.1800				
15 16	0.1397	0.0024		0.0008	0.0450		0.0028	80.7344	5.1800 5.2037	0.0016	0.0008	0.0018	
15 16 17 Mean	0.1397	0.0024		0.0008	0.0450 0.0507	<0.01	0.0028	80.7344 0.4373	5.1800 5.2037 5.2111	0.0016	0.0008	0.0018	
15 16 17 Mean STDV					0.0450 0.0507 0.0284	<0.01			5.1800 5.2037 5.2111 5.0419				
15 16 17 Mean	0.0142	0.0015		0.0005	0.0450 0.0507 0.0284 0.0104	<0.01 0.0058 0.0045	0.0035	0.4373	5.1800 5.2037 5.2111 5.0419 0.1085	0.0010	0.0002	0.0010	

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

